

<b>Notice of References Cited</b>	Application/Control No. 09/784,730	Applicant(s)/Patent Under Reexamination MIYAZAKI ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0037158	02-2003	YANO et al.	709/232
	B	US-6,065,059	05-2000	Shieh et al.	709/233
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
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	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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